

Notice of References Cited	Application/Control No. 10/707,353		Applicant(s)/Patent Under Reexamination LIN, YU-CHIEH	
	Examiner CHIA-WEI A. CHEN		Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,477,264	12-1995	Sarbadhikari et al.	348/231.6
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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